


Search Notes 	Application/Control No. 10551817	Applicant(s)/Patent Under Reexamination LIN ET AL.
	Examiner Cheng, Ichieh	Art Unit 4183

SEARCHED			
Class	Subclass	Date	Examiner
455	452.1-452.2	7/29/2008	SR
370	310.1,331,338	7/29/2008	SR

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	7/29/2008	SR

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner